

### 650V 4A Field Stop Trench IGBT

V <sub>CES</sub>	650V
I <sub>C(100°C)</sub>	4A
V <sub>CE(sat) (Typ.)</sub>	1.65V
$P_D$	65W

#### Features

- 1) Low Collector Emitter Saturation Voltage
- 2) Low Switching Loss
- 3) Short Circuit Withstand Time 5µs
- 4) Built in Very Fast & Soft Recovery FRD (RFN Series)
- 5) Pb free Lead Plating; RoHS Compliant

#### Applications

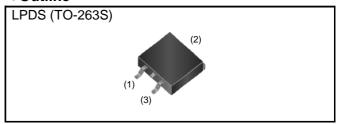
General Inverter

**UPS** 

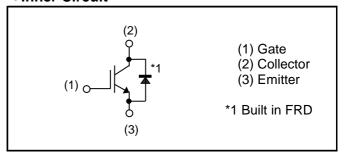
**Power Conditioner** 

Welder

#### Outline



#### ●Inner Circuit



Packaging Specifications

		Packaging	Taping	
		Reel Size (mm)	330	
	Typo	Tape Width (mm)	24	
	Type	Basic Ordering Unit (pcs)	1,000	
		Taping Code	TL	
		Marking	RGT8NS65D	

## ● Absolute Maximum Ratings (at T<sub>C</sub> = 25°C unless otherwise specified)

Parameter		Symbol	Value	Unit
Collector - Emitter Voltage		V <sub>CES</sub>	650	V
Gate - Emitter Voltage		$V_{GES}$	±30	V
Collector Current	T <sub>C</sub> = 25°C	I <sub>C</sub>	8	А
Collector Current	T <sub>C</sub> = 100°C	I <sub>C</sub>	4	А
Pulsed Collector Current		I <sub>CP</sub> *1	12	А
Diode Forward Current	$T_C = 25^{\circ}C$	I <sub>F</sub>	7	А
	T <sub>C</sub> = 100°C	I <sub>F</sub>	4	А
Diode Pulsed Forward Current		I <sub>FP</sub> *1	12	А
Power Dissipation	$T_C = 25^{\circ}C$	P <sub>D</sub>	65	W
	T <sub>C</sub> = 100°C	P <sub>D</sub>	32	W
Operating Junction Temperature		T <sub>j</sub>	-40 to +175	°C
Storage Temperature		$T_{stg}$	-55 to +175	°C

<sup>\*1</sup> Pulse width limited by T<sub>jmax.</sub>

#### ●Thermal Resistance

Parameter	Symbol	Values			Unit
- Farameter	Symbol	Min.	Тур.	Max.	Offic
Thermal Resistance IGBT Junction - Case	$R_{\theta(j-c)}$	-	-	2.30	°C/W
Thermal Resistance Diode Junction - Case	$R_{\theta(j-c)}$	-	-	8.70	°C/W

# ●IGBT Electrical Characteristics (at T<sub>j</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Conditions	Values			Unit
r ai ai nietei	Syllibol	Conditions	Min.	Тур.	Max.	Offic
Collector - Emitter Breakdown Voltage	BV <sub>CES</sub>	$I_C = 10 \mu A, V_{GE} = 0 V$	650	-	ı	V
Collector Cut - off Current	I <sub>CES</sub>	$V_{CE} = 650V, V_{GE} = 0V$	-	-	10	μΑ
Gate - Emitter Leakage Current	I <sub>GES</sub>	$V_{GE} = \pm 30V, V_{CE} = 0V$	-	•	±200	nA
Gate - Emitter Threshold Voltage	$V_{GE(th)}$	$V_{CE} = 5V, I_{C} = 2.8 \text{mA}$	5.0	6.0	7.0	V
Collector - Emitter Saturation Voltage	V <sub>CE(sat)</sub>	$I_{C} = 4A, V_{GE} = 15V$ $T_{j} = 25^{\circ}C$ $T_{j} = 175^{\circ}C$	-	1.65 2.1	2.1	V

# ●IGBT Electrical Characteristics (at T<sub>j</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Conditions		Unit		
Parameter 	Symbol	Conditions	Min.	Тур.	Max.	Offic
Input Capacitance	C <sub>ies</sub>	V <sub>CE</sub> = 30V	-	220	-	
Output Capacitance	C <sub>oes</sub>	$V_{GE} = 0V$	-	14	-	pF
Reverse Transfer Capacitance	C <sub>res</sub>	f = 1MHz	-	4.5	-	
Total Gate Charge	$Q_g$	V <sub>CE</sub> = 400V	-	13.5	-	
Gate - Emitter Charge	$Q_ge$	$I_C = 4A$	-	4	-	nC
Gate - Collector Charge	$Q_{gc}$	V <sub>GE</sub> = 15V	-	5.5	-	
Turn - on Delay Time	t <sub>d(on)</sub>	$I_C = 4A, V_{CC} = 400V$	-	17	-	
Rise Time	t <sub>r</sub>	$V_{GE} = 15V, R_G = 50\Omega$	-	36	-	
Turn - off Delay Time	t <sub>d(off)</sub>	T <sub>j</sub> = 25°C	-	69	-	ns
Fall Time	t <sub>f</sub>	Inductive Load	-	71	-	
Turn - on Delay Time	t <sub>d(on)</sub>	$I_C = 4A, V_{CC} = 400V$	-	17	-	
Rise Time	t <sub>r</sub>	$V_{GE} = 15V, R_G = 50\Omega$	-	37	-	20
Turn - off Delay Time	t <sub>d(off)</sub>	T <sub>j</sub> = 175°C	-	86	-	ns
Fall Time	t <sub>f</sub>	Inductive Load	-	72	-	
		$I_C = 12A, V_{CC} = 520V$				
Reverse Bias Safe Operating Area	RBSOA	$V_P = 650V, V_{GE} = 15V$	FU	LL SQUA	RE	-
		$R_G = 50\Omega, T_j = 175^{\circ}C$				
		$V_{CC} \le 360V$				
Short Circuit Withstand Time	t <sub>sc</sub>	V <sub>GE</sub> = 15V	5	-	-	μs
		T <sub>j</sub> = 25°C				

# ●FRD Electrical Characteristics (at T<sub>j</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Conditions	Values			l lmit
			Min.	Тур.	Max.	Unit
Diode Forward Voltage	V <sub>F</sub>	$I_F = 4A$ $T_j = 25$ °C $T_j = 175$ °C	-	1.45 1.4	1.9	V
Diode Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> = 4A	-	40	ı	ns
Diode Peak Reverse Recovery Current	I <sub>rr</sub>	$V_{CC} = 400V$ $di_F/dt = 200A/\mu s$	-	4.3	1	А
Diode Reverse Recovery Charge	$Q_{rr}$	T <sub>j</sub> = 25°C	-	0.09	1	μC
Diode Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> = 4A	-	94	ı	ns
Diode Peak Reverse Recovery Current	I <sub>rr</sub>	$V_{CC} = 400V$ $di_F/dt = 200A/\mu s$	-	5.4	1	А
Diode Reverse Recovery Charge	$Q_{rr}$	T <sub>j</sub> = 175°C	-	0.27	-	μC

Fig.1 Power Dissipation vs. Case Temperature

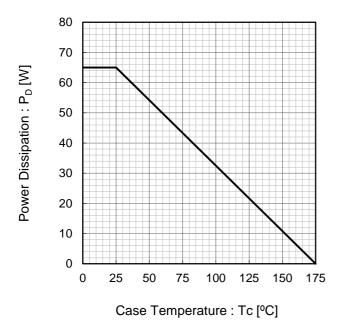


Fig.2 Collector Current vs. Case Temperature

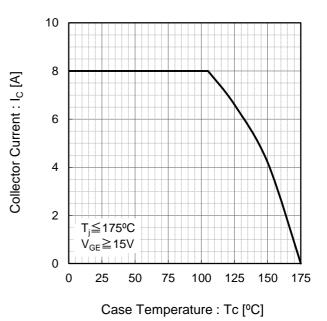
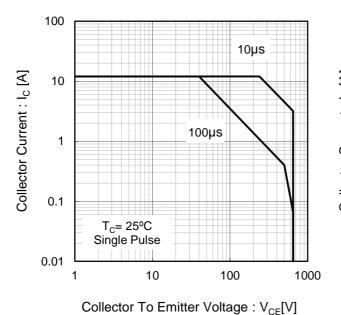


Fig.3 Forward Bias Safe Operating Area



Collector Current : I<sub>C</sub> [A]

16
14
12
10
8
6
4
2
-T<sub>j</sub>≤175°C
-V<sub>GE</sub>=15V
0
0 200 400 600 800

Fig.4 Reverse Bias Safe Operating Area

Collector To Emitter Voltage :  $V_{CE}[V]$ 

Fig.5 Typical Output Characteristics

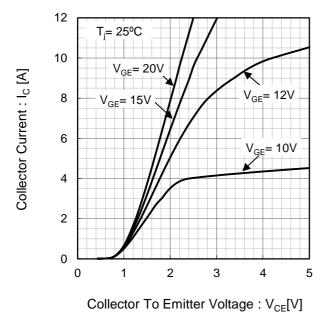
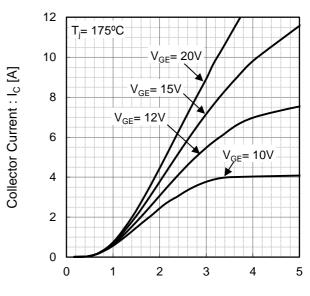


Fig.6 Typical Output Characteristics



Collector To Emitter Voltage : V<sub>CE</sub>[V]

Fig.7 Typical Transfer Characteristics

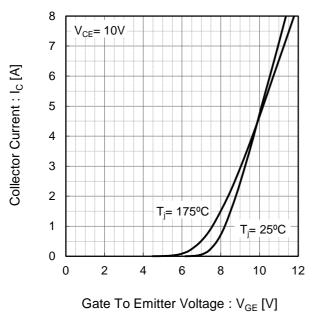
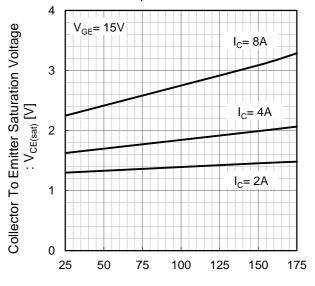
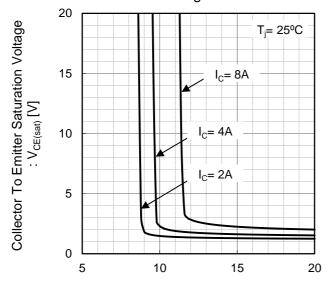


Fig.8 Typical Collector To Emitter Saturation Voltage vs. Junction Temperature



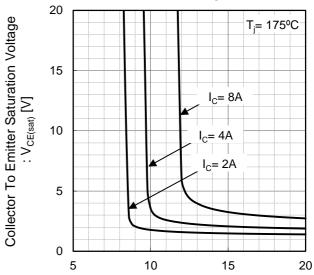
Junction Temperature : T<sub>i</sub> [°C]

Fig.9 Typical Collector To Emitter Saturation Voltage vs. Gate To Emitter Voltage



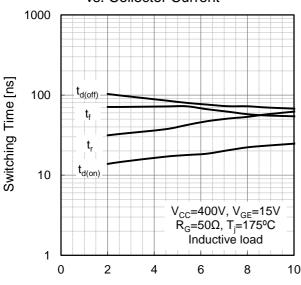
Gate To Emitter Voltage : V<sub>GE</sub> [V]

Fig.10 Typical Collector To Emitter Saturation Voltage vs. Gate To Emitter Voltage



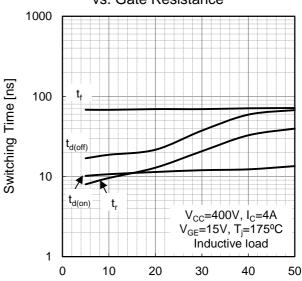
Gate To Emitter Voltage : V<sub>GE</sub> [V]

Fig.11 Typical Switching Time vs. Collector Current



Collector Current : I<sub>C</sub> [A]

Fig.12 Typical Switching Time vs. Gate Resistance



Gate Resistance :  $R_G[\Omega]$ 

Fig.13 Typical Switching Energy Losses vs. Collector Current

10

Sessor Vs. Collector Current

10  $E_{\text{off}}$   $V_{\text{CC}} = 400 \text{V}, V_{\text{GE}} = 15 \text{V}$   $R_{\text{G}} = 50 \Omega, T_{\text{j}} = 175 ^{\circ} \text{C}$ Inductive load

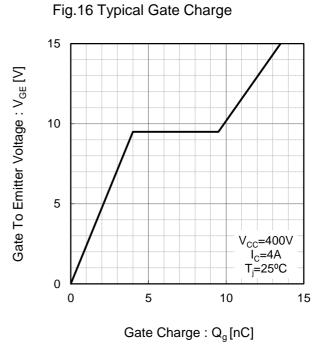
0.01

Collector Current:  $I_{\text{C}}$  [A]

vs. Gate Resistance 10 Switching Energy Losses [mJ] 1 0.1  $V_{CC}$ =400V,  $I_{C}$ =4A  $V_{GE}$ =15V,  $T_{j}$ =175°C  $\mathsf{E}_{\mathsf{on}}$ Inductive load 0.01 0 10 20 30 40 50 Gate Resistance :  $R_G[\Omega]$ 

Fig.14 Typical Switching Energy Losses

Fig.15 Typical Capacitance vs. Collector To Emitter Voltage 10000 1000 Capacitance [pF] Cies 100 Coes 10 f=1MHz Cres V<sub>GE</sub>=0V 0.01 0.1 1 10 100 Collector To Emitter Voltage : V<sub>CE</sub>[V]



vs. Forward Voltage

12

10

Voltage

12

10

4

2

T<sub>j</sub>= 175°C

0

1.5

Forward Voltage : V<sub>F</sub>[V]

2

2.5

3

Fig.17 Typical Diode Forward Current

vs. Forward Current 120 Reverse Recovery Time: t<sub>rr</sub> [ns] 100 80 T<sub>i</sub>= 175°C 60 40 T<sub>i</sub>= 25°C V<sub>CC</sub>=400V 20 di<sub>F</sub>/dt=200A/µs Inductive load 0 8 2 4 6 10 0

Fig.18 Typical Diode Reverse Recovery Time

Fig.19 Typical Diode Reverse Recovery Current vs. Forward Current

0.5

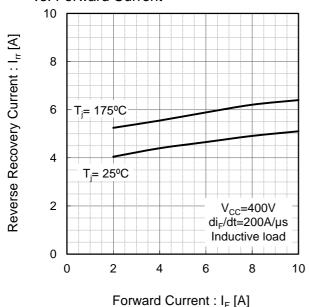


Fig.20 Typical Diode Reverse Recovery Charge vs. Forward Current

Forward Current : I<sub>F</sub> [A]

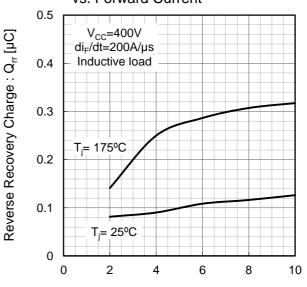
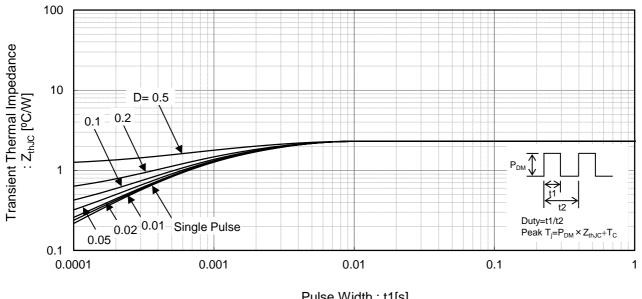
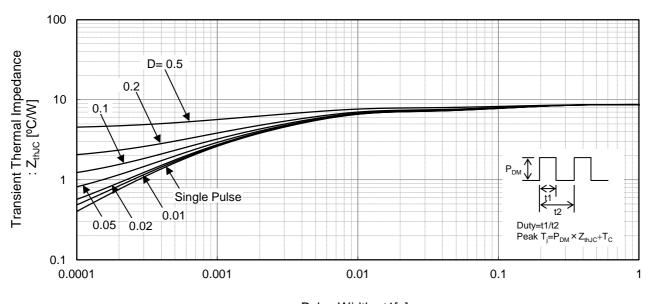


Fig.21 IGBT Transient Thermal Impedance



Pulse Width: t1[s]

Fig.22 Diode Transient Thermal Impedance



Pulse Width: t1[s]

### •Inductive Load Switching Circuit and Waveform

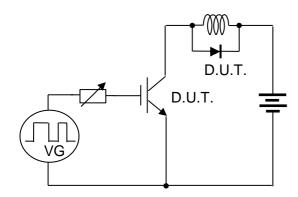


Fig.23 Inductive Load Circuit

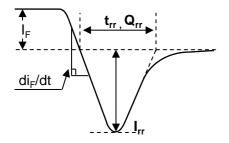


Fig.25 Diode Reverce Recovery Waveform

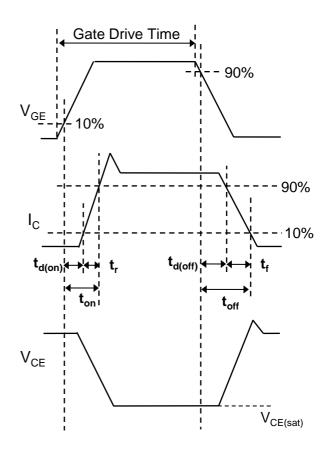


Fig.24 Inductive Load Waveform

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